TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (L^2 - π -MOSV)

2SJ402

DC-DC Converter, Relay Drive and Motor Drive Applications

• 4 V gate drive

• Low drain–source ON resistance : $RDS (ON) = 29 \text{ m}\Omega \text{ (typ.)}$

• High forward transfer admittance $: |Y_{fs}| = 23 \text{ S (typ.)}$ • Low leakage current $: I_{DSS} = -100 \,\mu\text{A (max) (V}_{DS} = -60 \,\text{V)}$

• Enhancement-mode : $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-60	V	
Drain-gate voltage (Ro	_{SS} = 20 kΩ)	V_{DGR}	-60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	-30	Α	
	Pulse(Note 1)	I _{DP}	-120	Α	
Drain power dissipation	n (Tc = 25°C)	P_{D}	100	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	936	mJ	
Avalanche current		I _{AR}	-30	Α	
Repetitive avalenche e	nergy (Note 3)	E _{AR}	10	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.25	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

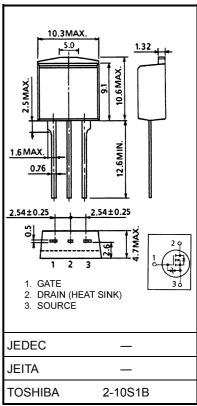
Note 2: V_{DD} = -50 V, T_{ch} = 25°C (initial), L = 747 μ H, R_{G} = 25 Ω , I_{AR} = -30 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

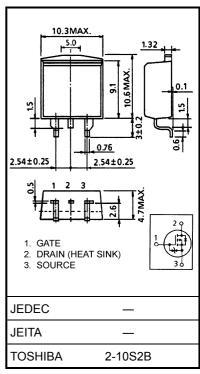
This transistor is an electrostatic sensitive device.

Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



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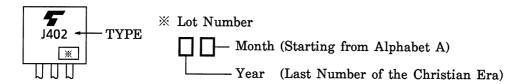
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V	_	_	-100	μΑ
Drain-source br	eakdown voltage	V _{(BR) DSS}	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-60	_	_	V
Gate threshold v	/oltage	V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = -4 V, I _D = -15 A	_	46	60	mΩ
			V _{GS} = -10 V, I _D = -15 A	_	29	38	11122
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -15 A	14	23	_	S
Input capacitano	ce	C _{iss}			3300	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	460	_	
Output capacitance		Coss]		1450	_	
Switching time	Rise time	t _r	$V_{GS} = 10V$ $V_{DD} = -30V$ $I_{D} = -15A$ V_{OUT} $R_{L} = 2\Omega$ $V_{DD} = -30V$	_	20	_	- ns
	Turn-on time	t _{on}		_	25	_	
	Fall time	t _f		_	35	_	
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{W} = 10 \mu s$	1	130		
Total gate charge (Gate-source plus gate-drain)		Qg		_	110	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx -48 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -30 \text{ A}$		75		nC
Gate-drain ("miller") charge		Q _{gd}		_	35		

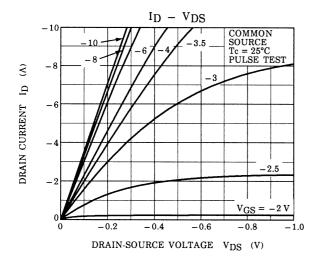
Source-Drain Ratings and Characteristics (Ta = 25°C)

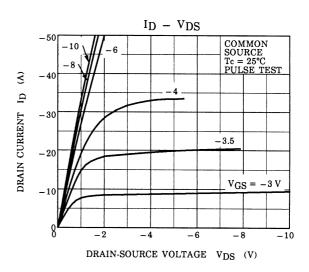
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-30	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	-120	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = -30 A, V _{GS} = 0 V	_	_	1.7	V
Reverse recovery time	t _{rr}	I _{DR} = -30 A, V _{GS} = 0 V		100	_	ns
Reverse recovery charge	Qrr	dI_{DR} / $dt = 50 A / \mu S$	_	0.16	_	μC

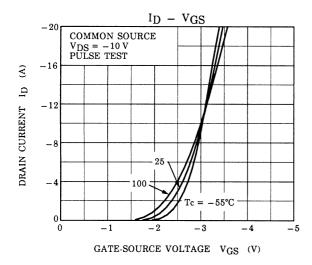
Marking

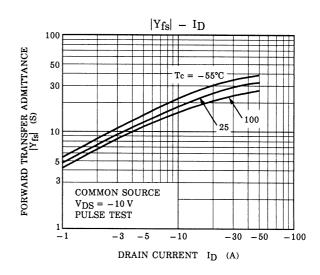


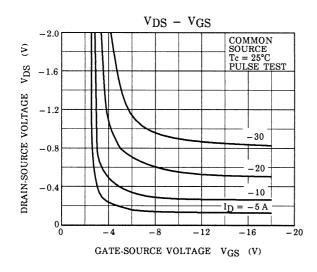
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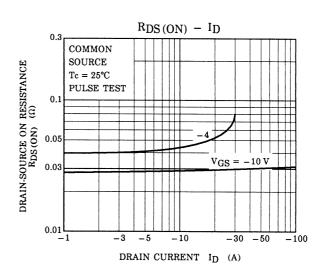




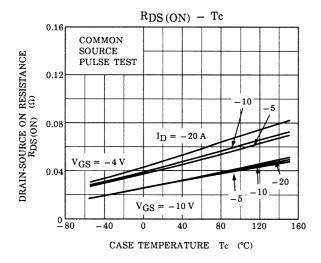


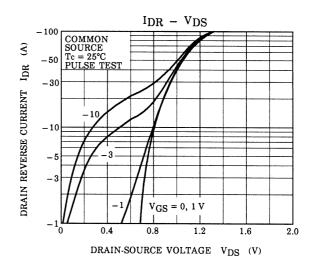


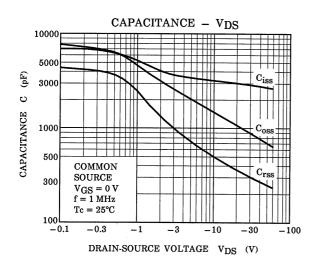


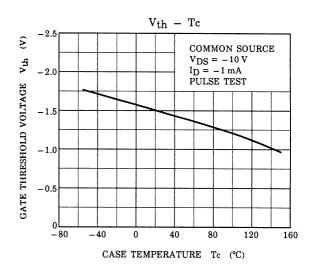


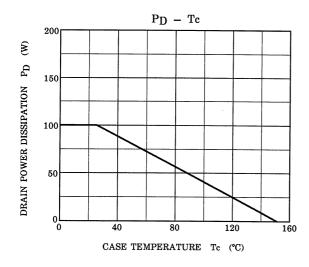
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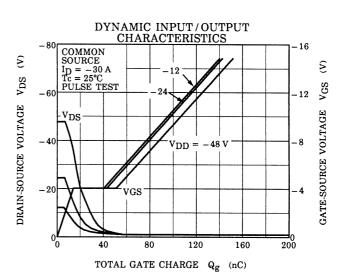




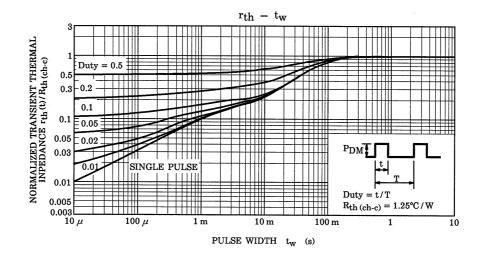


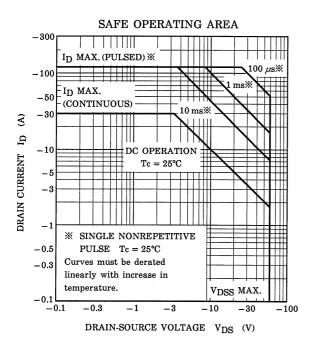


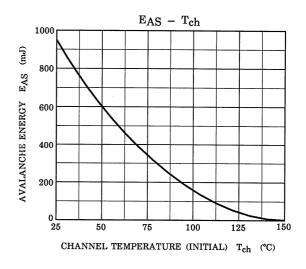


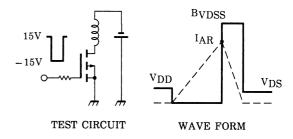


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$$\begin{array}{ll} R_G \!=\! 25\Omega \\ V_{DD} \!=\! -50V, \; L \!=\! 747 \mu H \end{array} \qquad E_{AS} \!=\! \frac{1}{2} \cdot L \cdot I^2 \cdot (\frac{B_{VDSS}}{B_{VDSS} \!-\! V_{DD}})$$

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